

Notice of References Cited	Application/Control No. 10/623,940	Applicant(s)/Patent Under Reexamination NAKAJIMA ET AL.	
	Examiner Nhan T. Tran	Art Unit 2622	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0041404	04-2002	Shinotsuka et al.	358/514
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*	D	US-6,141,450	10-2000	Chen et al.	382/237
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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